

Search Notes

Application/Control No.

10/758,400

Examiner

Alison K. Pickard

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

3673

SEARCHED

Class	Subclass	Date	Examiner
277	563	5/23/2005	AP
	585		
	552		
	502		
	607		
	615		
137	625.69		
	625.66		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east		